



Edition 1.1 2014-07 CONSOLIDATED VERSION

TECHNICAL REPORT



INTERNATIONAL SPECIAL COMMITTEE ON RADIO INTERFERENCE

Specification for radio disturbance and immunity measuring apparatus and methods –

Part 4-5: Uncertainties, statistics and limit modelling – Conditions for the use of alternative test methods

INTERNATIONAL ELECTROTECHNICAL COMMISSION

ICS 33.100.10; 33.100.20

ISBN 978-2-8322-1770-2

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REDLINE VERSION



INTERNATIONAL SPECIAL COMMITTEE ON RADIO INTERFERENCE

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Part 4-5: Uncertainties, statistics and limit modelling – Conditions for the use of alternative test methods



CONTENTS

FO	REWO	DRD	4
1	Scop	e	6
2	Norm	native references	6
3	Term	is and definitions	6
4	Syml	ools and abbreviated terms	8
5	Intro	duction	8
6	Proc	edure to derive limits for an alternative test method	9
	6.1	Overview	
	6.2	Select the reference quantity X	
	6.3	Describe the test methods and measurands	
	6.4	Determine the deviations of the measured quantities from the reference quantity	10
	6.5	Determine the average values of the deviations	
	6.6	Estimate the standard uncertainties of the test methods	
	6.7	Estimate the standard uncertainties of the test methods	
	6.8	Calculate the average conversion factor	
	6.9	Verify the calculated values	
		Apply the conversion	
7	Meas	surement-based procedure to derive limits for an alternative test method d on measurement results	
	7.1		
	7.2	Application of practical measurement results to determine the conversion	
۸		factors	
		(informative) Remarks on EUT modelling	21
		(informative) Examples of application of the test method comparison	22
		(informative) Example of the application of the test method comparison e based on measurement results	52
- C.		phy	
מום	liogra	pny	
Fig	ure 1	- Overview of quantities to estimate for use in conversion procedure.	10
Fig	ure 2	- Overview of limit conversion procedure using estimated quantities.	11
Fig	ure B.	1 – Example reference quantity	22
-		2 – EUT and antenna set-up for fully anechoic room emission measurement	
-		3 – EUT and antenna set-up for open-area test site measurement	
Fig	ure B.	4 – Radiation characteristics of elementary radiator (left), and scheme of del (right)	
		5 – Maximum average deviations for 3 m FAR (top) and 10 m OATS (bottom)	
-		6 – Sample cumulative distribution function	
-		7 – Uncertainties due to the unknown EUT characteristic for 3 m FAR (top)	29
and	1 10 m	OATS (bottom)	31
		8 – Expanded uncertainties (k = 2) of alternative (3 m FAR, top) and ed (10 m OATS, bottom) test methods	35
Fig	ure B.	9 – Maximum average conversion factors for different volumes	36
		10 - Photo (left) and cut-view of simulation model (right) of the specimen EUT	

CISPR TR 16-4-5:2006

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Figure B.11 – Deviations of the specimen EUT: 3 m fully anechoic room (top) and 10 m open area test site (bottom)	9
Figure B.12 – Sample FAR measurement	0
Figure B.13 – OATS 10 m limit line converted to FAR 3 m conditions4	0
Figure B.14 – Expanded uncertainties	0
Figure B.15 – Comparison of the measured values with the corrected converted limit4	1
Figure B.16 – EUT and antenna set-up of 3 m open area test site measurement4	2
Figure B.17 – Maximum average deviations for 3 m OATS4	3
Figure B.18 – Uncertainties due to the unknown EUT characteristic for 3 m OATS4	4
Figure B.19 – Expanded uncertainties ($k = 2$) of alternative test method [OATS (3 m)]4	6
Figure B.20 – Maximum average conversion factors4	7
Figure B.21 – Deviations of the specimen EUT: Open area test site (3 m)4	9
Figure B.22 – Sample OATS (3 m) measurement	0
Figure B.23 – OATS (10 m) limit line converted to OATS (3 m) conditions	0
Figure B.24 – Expanded uncertainties	1
Figure B.25 – Comparison of the corrected values with the converted limit	1
Figure C.1 – EUTs used during RRT	2
Figure C.2 – Measurement results of the asymmetrical voltage using both CDNEs	3
Figure C.3 – Measured disturbance field strength	4
Figure C.4 – Conversion factors of all measurements	5
Figure C.5 – Mean conversion factors for each EUT	5
Figure C.6 – Measured polarization	5
Figure C.7 – Comparison with CISPR 15:2013	5
Figure C.8 – Deviation of the conversion factors from the average conversion factor of each EUT	6
Figure C.9 – Deviation of the conversion factors from the trend line [poly (mean value $K(f)$)]	6
Table 1 – Summary of steps in conversion procedure	9

Table 1 – Summary of steps in conversion procedure	9
Table 2 – Overview of quantities and defining equations for conversion process	12
Table B.1 – Instrumentation uncertainty of the 3 m fully anechoic chamber test method	28
Table B.2 – Uncertainties in dB due to the unknown EUT characteristic for 3 m FAR	33
Table B.3 – Uncertainties in dB due to the unknown EUT characteristic for 10 m OATS	34
Table B.4 – Maximum average conversion factors in dBbetween 10 m OATS and3 m FAR	37
Table B.5 – Uncertainties in dB due to the unknown EUT characteristic for 3 m OATS	45
Table B.6 – Maximum average conversion factors in dB between 10 m and 3 m OATS	48

INTERNATIONAL ELECTROTECHNICAL COMMISSION

SPECIFICATION FOR RADIO DISTURBANCE AND IMMUNITY MEASURING APPARATUS AND METHODS –

Part 4-5: Uncertainties, statistics and limit modelling – Conditions for the use of alternative test methods

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CISPR TR 16-4-5 edition 1.1 contains the first edition (2006-10) [documents CISPR/ A/665/DTR and CISPR/A/685/RVC] and its amendment 1 (2014-07) [documents CISPR/ A/1050/DTR and CISPR/A/1069/RVC].

In this Redline version, a vertical line in the margin shows where the technical content is modified by amendment 1. Additions are in green text, deletions are in strikethrough red text. A separate Final version with all changes accepted is available in this publication. CISPR TR 16-4-5:2006 +AMD1:2014 CSV © IEC 2014 - 5 -

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CISPR 16-4-5, which is a technical report, has been prepared by CISPR subcommittee A: Radio-interference measurements and statistical methods.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts of the CISPR 16-4 series, published under the general title *Specification for* radio disturbance and immunity measuring apparatus and methods – Part 4: Uncertainties, statistics and limit modelling, can be found on the IEC website.

The committee has decided that the contents of the base publication and its amendment will remain unchanged until the stability date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

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SPECIFICATION FOR RADIO DISTURBANCE AND IMMUNITY MEASURING APPARATUS AND METHODS –

Part 4-5: Uncertainties, statistics and limit modelling – Conditions for the use of alternative test methods

1 Scope

This part of CISPR 16-4 specifies a method to enable product committees to develop limits for alternative test methods, using conversions from established limits. This method is generally applicable for all kinds of disturbance measurements, but focuses on radiated disturbance measurements (i.e. field strength), for which several alternative methods are presently specified. These limits development methods are intended for use by product committees and other groups responsible for defining emissions limits in situations where it is decided to use alternative test methods and the associated limits in product standards.

2 Normative references

IEC 60050-161:1990, International Electrotechnical Vocabulary (IEV) – Chapter 161: Electromagnetic compatibility

CISPR 16-4-1:2003, Specification for radio disturbance and immunity measuring apparatus and methods – Part 4-1: Uncertainties, statistics and limit modelling – Uncertainty in standardized EMC tests

CISPR 16-4-2:2003, Specification for radio disturbance and immunity measuring apparatus and methods – Part 4-2: Uncertainties, statistics and limit modelling – Uncertainty in EMC measurements





Edition 1.1 2014-07 CONSOLIDATED VERSION

FINAL VERSION



INTERNATIONAL SPECIAL COMMITTEE ON RADIO INTERFERENCE

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Part 4-5: Uncertainties, statistics and limit modelling – Conditions for the use of alternative test methods



CONTENTS

FO	REWC)RD	4
1	Scop	e	6
2	Norm	ative references	6
3	Term	s and definitions	6
4	Symb	ools and abbreviated terms	8
5	Introd	luction	8
6	Proce	edure to derive limits for an alternative test method	9
	6.1	Overview	9
	6.2	Select the reference quantity X	
	6.3	Describe the test methods and measurands	.13
	6.4	Determine the deviations of the measured quantities from the reference	4.0
	6 5	quantity Determine the average values of the deviations	
	6.5 6.6	Estimate the standard uncertainties of the test methods	
	6.7	Estimate the standard uncertainties of the test methods	
	6.8	Calculate the average conversion factor	
	6.9	Verify the calculated values	
	6.10	Apply the conversion	
7		urement-based procedure to derive limits for an alternative test method d on measurement results	. 17
	7.1	General	.17
	7.2	Application of practical measurement results to determine the conversion factors	.18
Anr	nex A	(informative) Remarks on EUT modelling	.21
		(informative) Examples of application of the test method comparison	.22
		(informative) Example of the application of the test method comparison e based on measurement results	.52
•		ohy	
Fig	ure 1 -	- Overview of quantities to estimate for use in conversion procedure	.10
Fig	ure 2 -	- Overview of limit conversion procedure using estimated quantities.	.11
Fig	ure B.	1 – Example reference quantity	.22
Fig	ure B.	2 – EUT and antenna set-up for fully anechoic room emission measurement	.23
Fig	ure B.	3 – EUT and antenna set-up for open-area test site measurement	.23
		4 – Radiation characteristics of elementary radiator (left), and scheme of el (right)	.24
Fig	ure B.	5 – Maximum average deviations for 3 m FAR (top) and 10 m OATS (bottom)	.27
Fig	ure B.	6 – Sample cumulative distribution function	.29
Fig	ure B.	7 – Uncertainties due to the unknown EUT characteristic for 3 m FAR (top) OATS (bottom)	
Fig	ure B.	8 – Expanded uncertainties (<i>k</i> = 2) of alternative (3 m FAR, top) and ed (10 m OATS, bottom) test methods	
		9 – Maximum average conversion factors for different volumes	
		10 – Photo (left) and cut-view of simulation model (right) of the specimen EUT	

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Figure B.11 – Deviations of the specimen EUT: 3 m fully anechoic room (top) and 10 m open area test site (bottom)	39
Figure B.12 – Sample FAR measurement	40
Figure B.13 – OATS 10 m limit line converted to FAR 3 m conditions	40
Figure B.14 – Expanded uncertainties	40
Figure B.15 – Comparison of the measured values with the corrected converted limit	41
Figure B.16 – EUT and antenna set-up of 3 m open area test site measurement	42
Figure B.17 – Maximum average deviations for 3 m OATS	43
Figure B.18 – Uncertainties due to the unknown EUT characteristic for 3 m OATS	44
Figure B.19 – Expanded uncertainties ($k = 2$) of alternative test method [OATS (3 m)]	46
Figure B.20 – Maximum average conversion factors	47
Figure B.21 – Deviations of the specimen EUT: Open area test site (3 m)	49
Figure B.22 – Sample OATS (3 m) measurement	50
Figure B.23 – OATS (10 m) limit line converted to OATS (3 m) conditions	50
Figure B.24 – Expanded uncertainties	51
Figure B.25 – Comparison of the corrected values with the converted limit	51
Figure C.1 – EUTs used during RRT	52
Figure C.2 – Measurement results of the asymmetrical voltage using both CDNEs	53
Figure C.3 – Measured disturbance field strength	54
Figure C.4 – Conversion factors of all measurements	55
Figure C.5 – Mean conversion factors for each EUT	55
Figure C.6 – Measured polarization	55
Figure C.7 – Comparison with CISPR 15:2013	55
Figure C.8 – Deviation of the conversion factors from the average conversion factor of	FG
each EUT	50
Figure C.9 – Deviation of the conversion factors from the trend line [poly (mean value <i>K</i> (<i>f</i>))]	56
Table 1 – Summary of steps in conversion procedure	9
Table 2 – Overview of quantities and defining equations for conversion process	12
Table B.1 – Instrumentation uncertainty of the 3 m fully anechoic chamber test method	28
Table B.2 – Uncertainties in dB due to the unknown EUT characteristic for 3 m FAR	33
Table B.3 – Uncertainties in dB due to the unknown EUT characteristic for 10 m OATS	34
Table B.4 – Maximum average conversion factors in dB between 10 m OATS and	
3 m FAR	37

3 III FAR
Table B.5 – Uncertainties in dB due to the unknown EUT characteristic for 3 m OATS48
Table B.6 – Maximum average conversion factors in dB between 10 m and 3 m OATS48

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